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Nobuharu Noji, I Tohru Satake, K Masahiro Hatak Toshifumi Kimbi Hirosi Sobukawa Shoji Yoshikawa Takeshi Muraka Kenji Watanabe Tsutomu Karima Shin Oowada, K Mutsumi Saito, I Yuichiro Yamaz Takamitsu Naga Ichirota Nagaha ** CONTINUING DATA ** FOREIGN APPLICA JAPAN 2000-19 JAPAN 2000-22 JAPAN 2001-31 JAPAN 2001-31 JAPAN 2001-31 JAPAN 2001-35 JAPAN 2001-16 JAPAN 2001-18	1100	PAN;	BLE COL	JIAVA TZ
Foreign Priority claimed 35 USC 119 (a-d) conditions met Verified and Acknowledged	yes no Met efter Allowance Duman	STATE OR COUNTRY JAPAN	DRAWING CL	OTAL INDEPENDENT AIMS CLAIMS 60 13
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Inspection system by charged particle beam and method of manufacturing devices using the system